EFFECT OF MORPHOLOGY OF $\gamma'$ PHASE ON CREEP RESISTANCE OF A SINGLE CRYSTAL NICKEL-BASED SUPERALLOY, CMSX-4

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Abstract

The influence of the formation of a lamellar $\gamma$-$\gamma'$ structure on creep resistance was investigated using the single crystal nickel-base superalloy, CMSX-4. The evolution of lamellae, or rafts was controlled by the duration of the prior-creep test conducted at 1273K-160MPa up to 3.24x10^8. Under these conditions, the cuboidal $\gamma'$ phase in the as-heat treated specimens was always larger than that of the as-heat treated one. The dislocation substructure was not formed in the cuboidal $\gamma'$ and rafted $\gamma'$, and was observed at the $\gamma'$/$\gamma$ interface and $\gamma$ channel. The thickness of the $\gamma$ channel increased with increasing the prior-creep testing time. The correlation between the thickness of the $\gamma$ channel and the minimum creep rate in the stress enhanced creep test was directly proportional to the thickness of the $\gamma$ channel. Consequently, the loss of creep resistance through rafting of $\gamma'$ is caused by the increase in the radius of dislocation curvature, not by the shape and the size of $\gamma'$.

Introduction

Excellent creep resistance at high temperature of advanced single crystal nickel-based superalloys is derived from the large volume fraction more than 70% of intermetallic Ni$_3$(Al,Ti) precipitate, known as $\gamma'$, and from the regular array of the cuboidal $\gamma'$ precipitate. By submitting to the creep deformation under the conditions of higher temperatures and relatively lower stresses, the cuboidal $\gamma'$ precipitates in the [001] orientation were interrupted in the wide region ranging from a transient creep stage to an accelerating creep stage. The stress enhanced creep tests were performed only by increasing the applied stress without changing the testing temperature. The change in creep resistance of the specimens submitted to the creep was discussed by correlating with the change in $\gamma'$ precipitate morphology to identify that the rafted structure of $\gamma'$ precipitates acts as a creep strengthener or as a creep weakener.

Experimental procedure

Single crystals of CMSX-4 (analyzed composition in weight percent; 6.4Cr, 9.3Co, 5.5Al, 0.9Ti, 6.3Mo, 6.2Ta, 6.2W, 2.8Re, 0.1Hf, balance Ni) were prepared in the form of bars 13mm in diameter by directional solidified casting. The exact orientations were determined by the Laue back-reflection technique; longitudinal axes of single crystals selected for this study were within 5deg of the [001] orientation. After employing a eight steps solid solution treatment*1 and a two steps aging heat treatment*2, the prior-creep tests were carried out at 1273K and 160MPa creep treated one*3.

To evaluate creep resistance of the specimens subjected to the creep deformation, a stress enhanced creep test is applied to the prior creep tested specimen. To avoid the microstructural change, the stress enhanced creep test is preferable to the temperature enhanced creep test. Unfortunately, in both studies done by Pearson and by Nathal, temperatures in the stress enhanced creep test were reduced, thereby the enhanced stress seems to be high enough to allow the dislocations to cut the cuboidal $\gamma'$ precipitate. The effect of $\gamma'$ morphology on creep resistance should be discussed under the conditions where dislocation climb in the $\gamma$ channel is predominant, because the prior-creep tests done to make the rafted specimens must be undertaken at the condition where the dislocation climb is predominant. Therefore the stress levels in the stress enhanced creep tests done by Pearson and Nathal are both unsuitable. Systematic research programs interrupting the creep tests at various times ranging from a transient creep stage to an accelerating creep stage have been desired to elucidate the correlation between the formation of the rafted structure and creep resistance.

In this study, the creep tests for the single crystals oriented in the [001] orientation were interrupted in the wide region ranging from a transient creep stage to an accelerating creep stage. The stress enhanced creep tests were performed only by increasing the applied stress without changing the testing temperature. The change in creep resistance of the specimens submitted to the creep was discussed by correlating with the change in $\gamma'$ precipitate morphology to identify that the rafted structure of $\gamma'$ precipitates acts as a creep strengthener or as a creep weakener.

*1 Solid solution treatment: 1550Kx7.2ks $\rightarrow$ 1561Kx7.2ks $\rightarrow$ 1569Kx10.8ks $\rightarrow$ 1586Kx7.2ks $\rightarrow$ 1589Kx7.2ks $\rightarrow$ 1591Kx7.2ks $\rightarrow$ 1594Kx7.2ks $\rightarrow$ GFC

*2 Aging heat treatment: 1413Kx21.6ks $\rightarrow$ 1144Kx72ks $\rightarrow$ AC
rupture life is $3.60 \times 10^6$ s), using the specimens with a gauge diameter of 8.0 mm and a gauge length of 50 mm, and were interrupted at various times ranging from the transient creep stage to the accelerating creep stage. All the creep interrupted specimens were followed by cooling under load. The prior-creep tested specimens were re-machined into the specimens for the stress enhanced creep tests with a gauge diameter of 6.0 mm and a gauge length of 30 mm to remove the surface cracks. The stress enhanced creep tests were performed at 1273 K and 250 MPa. Creep strain was measured automatically through linear variable differential transformers (LVDT’s) attached to extensometers. Microstructural examinations by SEM and TEM were carried out on specimens cut parallel to (100) planes. Specimens for the SEM observation were prepared metallographically and electroetched with a supersaturated phosphoric acid-chromic acid solution. TEM foils were electropolished with a 5% solution of perchloric acid in alcohol. The volume fraction of the $\gamma'$ phase was measured by use of image processing facilities. The ratio of the average width to the length in the $\gamma'$ phase was defined as the aspect ratio and measured as a function of the prior creep testing time.

**Results**

**Microstructure of the as-heat treated specimen**

The microstructure of the as-heat treated specimen of CMSX-4 is shown in Fig. 1. No eutectic $\gamma'$ phase was observed and the cuboidal $\gamma'$ phase was regularly present in the $\gamma$ matrix. The average edge length of the cuboidal $\gamma'$ particles was controlled to be about 0.5 μm and the width of the $\gamma$ channel was estimated approximately 0.09 μm.

**Prior-creep test**

The creep rate-time curve in the prior-creep test at 1273 K-160 MPa of the as-heat treated specimen is shown in Fig. 2. The open circles correspond to time where the prior-creep tests were interrupted to prepare the specimens for the stress enhanced creep test. The minimum creep rate was attained at about 10⁻⁴ s⁻¹, and the prior-creep testing time extended over a wide range from the latter half of the transient creep stage to the late accelerating creep stage.

**Microstructure of the prior-creep tested specimens**

The scanning electron micrographs of the specimens prior-creep tested for $1.08 \times 10^6$ and $3.24 \times 10^6$ s are shown in Fig. 3. The $\gamma$ phase coalesced with each other and the lamellar $\gamma-\gamma'$ structures, that is rafted $\gamma$ structures, formed perpendicular
Changes in the volume fraction and the aspect ratio of the γ' phase with the prior-creep testing time at 1273K.

Fig. 4.

Creep rate-time curves at 1273K-250MPa of the specimens as-heat treated and prior-creep tested for 1.08x10^6 and 3.24x10^6s.

Fig. 5.

to the stress axis was observed in the specimen prior-creep tested for 1.08x10^6s. However, the further coarsening of the γ' phase was detected in the specimen prior-creep tested for 3.24x10^6s. And the lamellar γ-γ' structure was out of shape. The changes in the volume fraction and the aspect ratio of the γ' phase with the prior-creep testing time are shown in Fig. 4. The volume fraction of the γ' phase shown in the solid symbol was approximately 76%, independent of the prior-creep testing time. Precipitation of the γ' phase seems to be finished through the pre-heat treatment. The aspect ratio of the γ' phase increased after subjecting the prior-creep tests beyond 1.08x10^6s, and reached to the maximum value of 7 at 1.08x10^6s. However, this maximum value of the aspect ratio decreased with increasing the prior-creep testing time and attained to about 2 at 3.24x10^6s. The lamellar γ-γ' structures showing the maximum aspect ratio were formed at the stage where creep rate reached the minimum. Therefore, the lamellar structure was defined as the unstable structure, and the change in the shape of γ' phase was proceeding with the prior-creep testing time through the accelerating creep stage.

Stress enhanced creep test

The creep rate-time curves at 1273K-250MPa of the specimens as-heat treated and prior-creep tested for 1.08x10^6 and 3.24x10^6s are shown in Fig. 5. The minimum creep rate of the specimen prior-creep tested for 1.08x10^6s was about three times that of the as-heat treated one. And the minimum creep rate of the specimen prior-creep tested for 3.24x10^6s showed twenty times larger value than that of the as-heat treated one.

The minimum creep rates obtained by the stress enhanced creep test are plotted as a function of the prior-creep testing time in Fig. 6. The minimum creep rate of the prior-creep tested specimens increased gradually up to 3x10^6s with increasing the prior-creep testing time. Namely, the minimum creep rate of the specimen prior-creep tested for 7x10^6s to 2x10^7s with the lamellar γ-γ' structures was three to five times that of the as-heat treated one with the cuboidal γ' phase. And the minimum creep rate of the specimen prior-creep tested for 3.24x10^6s when the lamellar γ-γ' structures was out of shape, showed twenty times that of the as-heat treated one. Therefore, creep resistance of CMSX-4 decreased remarkably with increasing the prior-creep testing time.

Discussion

In general, the loss of strength of the polycrystalline heat-resistant alloys due to high temperature creep is thought to result from mechanical damage such as initiation and propagation of cracks at grain boundary. CMSX-4 used in this study, however, is the single crystal alloy and the surface layer of 1mm in thickness of the prior-creep tested specimens was eliminated by re-machining after the prior-creep tests. The rupture elongation of the prior-creep tested specimens was constant, independent of the prior-creep testing time. Therefore, it was difficult to interpret that the loss of creep resistance due to the prior-creep test caused by mechanical damage. On the other hand, it was reported that the loss of strength of the polycrystalline heat-resistant alloys due to high temperature creep was attributed to deterioration such as degradation of deformation resistance caused by coalescence and coarsening of carbides and precipitation of
Fig. 7. Transmission electron micrograph of the as-heat treated specimen crept up to the minimum creep rate at 1273K-250MPa. Stress axis is vertical on this photo.

Fig. 8. Transmission electron micrograph of the specimen prior-creep tested for $1.08 \times 10^5$ and crept up to the minimum creep rate at 1273K-250MPa. Stress axis is vertical on this photo.

Fig. 9. Transmission electron micrograph of the specimen prior-creep tested for $3.24 \times 10^5$ and crept up to the minimum creep rate at 1273K-250MPa. Stress axis is vertical on this photo.

Fig. 10. Change in the $\gamma$ channel thickness of the specimens as-heat treated and the prior-creep tested with the prior-creep testing time.

Few dislocations were observed in the $\gamma$ matrix and a small number of dislocations were present on the $\gamma \gamma'$ interface. The transmission electron microstructure of the specimen prior-creep tested for $1.08 \times 10^5$ and interrupted the stress enhanced creep test at the time showing the minimum creep rate, which was about five times that of the as-heat treated one, is shown in Fig. 8, where $B = [100]$. The dark regions were locally formed in the $\gamma$ matrix and was derived from the dislocation density. A number of dislocations were observed on the $\gamma \gamma'$ interface. The transmission electron microstructure of the specimen prior-creep tested for $3.24 \times 10^5$ and interrupted the stress enhanced creep test at the time showing the minimum creep rate, which was about twenty times that of the as-heat treated one, is shown in Fig. 9, where $B = [100]$. In the $\gamma$ matrix, the dark regions were also observed. By comparing the area of the dark region with that of the specimen prior-creep tested for $1.08 \times 10^5$, the dark region increased with increasing the prior creep testing time. A number of dislocations were also observed in the $\gamma$ matrix and a small number of dislocations were present on the $\gamma \gamma'$ interface. The transmission electron microstructure of the specimen prior-creep tested for $1.08 \times 10^5$ and interrupted the stress enhanced creep test at the time showing the minimum creep rate, which was about five times that of the as-heat treated one, is shown in Fig. 8, where $B = [100]$. The dark regions were locally formed in the $\gamma$ matrix and was derived from the dislocation density. A number of dislocations were observed on the $\gamma \gamma'$ interface. The transmission electron microstructure of the specimen prior-creep tested for $3.24 \times 10^5$ and interrupted the stress enhanced creep test at the time showing the minimum creep rate, which was about twenty times that of the as-heat treated one, is shown in Fig. 9, where $B = [100]$. In the $\gamma$ matrix, the dark regions were also observed. By comparing the area of the dark region with that of the specimen prior-creep tested for $1.08 \times 10^5$, the dark region increased with increasing the prior creep testing time. A number of dislocations were also observed in the $\gamma$ matrix and a small number of dislocations were present on the $\gamma \gamma'$ interface.
present on the γ′/Y' interface. From the results that few dislocations existed within rafted γ′, it was supposed that the creep deformation within the γ channel was predominant, compared with the rafted γ′. So, the movement of the dislocation within the thin γ channel appeared to be strongly restricted. From the SEM observation of the specimens as-heat treated and prior-creep tested for 1.08×10^5 and 3.24×10^5 as shown in Figs. 1 and 3, the γ channel thickness seems to increase with increasing the prior-creep testing time. Releasing the dislocations from the restriction of the thin γ channel through increasing the γ channel thickness seems the substantial mechanism to increase the creep rate. The γ channel thickness was measured on the as-heat treated and the prior-creep tested specimens. The γ channel thickness of the as-heat treated and the prior-creep tested specimens interrupted at the time showing the minimum creep rate was plotted as a function of the prior-creep testing time as shown in Fig. 10. The specimens subjected the longer prior-creep tests provide the thicker γ channel. The γ channel thickness of the specimens prior-creep tested for 2×10^5 and 3×10^5 were approximately twice and three times that of the as-heat treated one with the cuboidal γ phase, respectively. The minimum creep rate of the prior-creep tested specimens was plotted as a function of the γ channel thickness, as indicated in Fig. 11. The correlation between the minimum creep rate and the γ channel thickness showed linear, independent of the shape of γ. Consequently, creep resistance of single crystal nickel-based superalloys depends on the γ channel thickness. The reason was discussed why creep resistance decreased with an increase in the γ channel thickness. The high magnification transmission electron microstructures of the specimens prior-creep tested for 1.08×10^5, 1.08×10^6 and 3.24×10^5 are shown in Fig. 12, where B=[100]. The bent dislocation with the small radius of curvature was observed within the γ channel of the specimen prior-creep tested for 1.08×10^5. The radius of dislocation curvature of the specimen prior-creep tested for 1.08×10^6 was larger than that of the specimen prior-creep tested for 1.08×10^5 and smaller than that of the specimen prior-tested for 3.24×10^5. The radius of dislocation curvature seems to increase with an increase in the prior-creep testing time. It is well known that
The minimum creep rate of the fine- and the standard-γ specimens obtained by the stress enhanced creep test at 1273K-250MPa was plotted as a function of the prior-creep testing time as shown in Fig. 16. The minimum creep rate of the as-heat treated specimens with fine γ' was approximately 1/10 of that of the as-heat treated one with standard γ'. The minimum creep rate of the fine- and the standard-γ specimens increased with increasing the prior-creep testing time. The increasing ratio of the minimum creep rate with increasing the prior-creep testing time in the fine-γ' specimen was larger than that of standard-γ' specimen, and the minimum creep rate of the fine-γ' specimen prior-creep tested for $2.52 \times 10^6$ s was approximately equal to that of the standard-γ' specimen.

The minimum creep rate in the fine- and the standard-γ' specimens, was plotted as a function of the γ channel thickness. Fig. 15. Change in the γ channel thickness of the fine-γ' specimen as-heat treated and prior-creep tested with the prior-creep testing time compared with that of the standard-γ' specimen.

To confirm the above results, a similar investigation is made on the single crystal nickel-base superalloy, CMSX-4, with the fine γ' phase which was obtained by a two steps aging heat treatment for γ' refining (1323Kx21.6ks → 1144Kx72ks → Water quench) after a standard eight steps solid solution treatment and the results of the fine-γ' specimen are compared with those of the standard-γ' one.

The microstructure of the fine-γ specimen in the as-heat treated condition is shown in Fig. 14. The cuboidal γ' phase was regularly present in the γ matrix. The average edge length of the cuboidal γ' particles was shorter and the γ channel thickness was thinner than those of the standard-γ CMSX-4 which was shown in Fig. 1.

The γ channel thickness of the fine-γ specimen was plotted as a function of the prior-creep testing time compared with that of standard-γ specimen, as shown in Fig. 15. The γ channel thickness of the as-heat treated specimens with fine γ' was approximately 2/3 of that of the as-heat treated one with standard γ'. The both specimens subjected the longer prior-creep tests provided the larger γ channel thickness. The magnitude of the increase in the γ channel thickness of the fine-γ specimens with an increase in the prior-creep testing time was larger than that of standard-γ specimen, and by the prior-creep test for $2.52 \times 10^6$, the γ channel thickness of the
thickness, as indicated in Fig. 17. The correlation between the minimum creep rate and the γ channel thickness showed linear, independent of the shape and the size of γ'. Consequently, creep resistance of single crystal nickel-based superalloys directly depends on the γ channel thickness.

Conclusions

High temperature creep resistance of the prior-creep tested single crystal nickel based superalloy, CMSX-4, was investigated in connection with the morphology of the γ' phase. The results can be summarized in the following:

1) The γ-γ' lamellar structures were formed perpendicular to the stress axis during the transient creep stage, but regularity of the rafted γ' diminished during the long term prior-creep test.
2) The volume fraction of the γ' phase was constant independent of the prior-creep testing time. The aspect ratio of the γ' phase of the prior-creep tested specimens increased with an increase in the prior-creep testing time and the correlation between the minimum creep rate and the γ channel thickness showed linear, independent of the shape and the size of γ'. It was concluded that the creep resistance of single crystal nickel-based superalloys depends on the radius of dislocation curvature which was based on the γ channel thickness, independent of the shape and the size of γ'.

Reference


